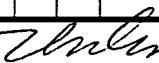
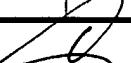


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/812,890	JAPP ET AL.
	Examiner Thinh T. Nguyen	Art Unit 2818

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
257	762	257	762 760
INTERNATIONAL CLASSIFICATION			
H	0	1	L 23/52
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			/
 Thinh T. Nguyen - 01/2006 (Assistant Examiner) (Date)			
 David Nelms Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)  1/16/04			
Total Claims Allowed: 15			
		O.G. Print Claim(s) 1	O.G. Print Fig. FIG 6

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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